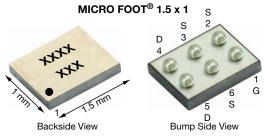


Vishay Siliconix

P-Channel 12 V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (Ω) (MAX.)	I _D (A) ^e	Q _g (TYP.)				
-12	0.026 at V _{GS} = -4.5 V	-16					
	0.035 at V _{GS} = -2.5 V	-16	21 nC				
	0.055 at V _{GS} = -1.8 V	-13	21110				
	0.092 at V _{GS} = -1.5 V	-2.5					



Marking Code: xxxx = 8483

xxx = Date / lot traceability code

Ordering Information:

Si8483DB-T2-E1 (Lead (Pb)-free and halogen-free)

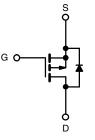
FEATURES

- TrenchFET® power MOSFET
- Ultra-small 1.5 mm x 1 mm maximum outline
- Ultra-thin 0.59 mm maximum height
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912



APPLICATIONS

- Load switch for smart phones, tablet PCs, and mobile computing
 - Low voltage drop
 - Low power consumption
 - Increased battery life



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_A = 25 ^{\circ}C$, unless	otherwise note	d)	
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	-12	V	
Gate-Source Voltage	V _{GS}	± 10	7 v	
	T _C = 25 °C		-16	
Continuous Drain Current (T. 150 °C)	T _C = 70 °C	, [-15	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	-8.7 ^{a, b}	
	T _A = 70 °C		-7 a, b	Α
Pulsed Drain Current		I _{DM}	-25	
Osalis a a Osaga Bais Bisda Osaga	T _C = 25 °C		-10.8	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	-2.3 a, b	
	T _C = 25 °C		13	
Mayimum Bayyar Dissination	T _C = 70 °C	ь Г	8.4	\Box w
Maximum Power Dissipation	T _A = 25 °C	P _D	2.77 ^{a, b}	vv
	T _A = 70 °C		1.77 ^{a, b}	7
Operating Junction and Storage Temperature R	T _J , T _{stg}	-55 to +150	°C	
Package Reflow Conditions ^c	IR/Convection		260	7

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a, f	R _{thJA}	37	45	°C/W			
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	7	9.5	- C/VV		

Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Case is defined as the top surface of the package.
- e. Based on $T_C = 25$ °C.
- f. Maximum under steady state conditions is 85 °C/W.



Vishay Siliconix

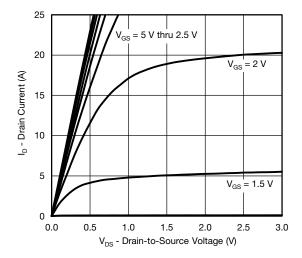
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)								
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Static				1	ı	ı		
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0$, $I_D = -250 \mu A$	-12	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = -250 μA	-	-7	-	mV/°C		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 = 200 μ/ (-	2.8	-			
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-	-0.8	V		
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$	-	-	± 100	nA		
Zoro Coto Voltago Dunio Comunit	1	$V_{DS} = -12 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μΑ		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -12 V, V _{GS} = 0 V, T _J = 70 °C	-	-	-10			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-5	-	-	Α		
		V _{GS} = -4.5 V, I _D = -1.5 A	-	0.022	0.026			
Duein Course On State Besistance 3	Б	V _{GS} = -2.5 V, I _D = -1.5 A	-	0.028	0.035	_		
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = -1.8 V, I _D = -1 A	-	0.040	0.055	Ω		
		V _{GS} = -1.5 V, I _D = -0.5 A	-	0.056	0.092	1		
Forward Transconductance a	9 _{fs}	V _{DS} = -6 V, I _D = -1.5 A	-	10	-	S		
Dynamic ^b	9.1					l		
Input Capacitance	C _{iss}		_	1840	_	pF		
Output Capacitance	C _{oss}	V _{DS} = -6 V, V _{GS} = 0 V, f = 1 MHz	-	410	-			
Reverse Transfer Capacitance	C _{rss}		-	380	-			
· · · · · · · · · · · · · · · · · · ·		V _{DS} = -6 V, V _{GS} = -10 V, I _D = -1.5 A	-	43	65			
Total Gate Charge	$egin{array}{c} Q_{g} \ & Q_{gs} \ & Q_{gd} \ \end{array}$	V _{DS} = -6 V, V _{GS} = -4.5 V, I _D = -1.5 A	-	21	32	nC		
Gate-Source Charge			_	2.1	-			
Gate-Drain Charge			-	4.8	-			
Gate Resistance	R _g	V _{GS} = -0.1 V, f = 1 MHz	-	2.2	-	Ω		
Turn-On Delay Time	t _{d(on)}	143 3111, 11111	-	20	40			
Rise Time	t _r	V_{DD} = -6 V, R_L = 4 Ω	_	25	50	ns		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.5 \text{ A, V}_{GEN} = -4.5 \text{ V, R}_g = 1 \Omega$	_	40	80			
Fall Time	t _f		_	10	20			
Turn-On Delay Time	t _{d(on)}			10	20			
Rise Time	t _r	$V_{DD} = -6 \text{ V. R}_{L} = 4 \Omega$		10	20			
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong -1.5 \text{ A}, V_{GEN} = -10V, R_{q} = 1 \Omega$		40	80			
Fall Time	t _f	J J J J J J J J J J J J J J J J J J J		10	20			
Drain-Source Body Diode Characteri	· ·			1 10		<u> </u>		
Continuous Source-Drain Diode	31103							
Current	I _S	$T_C = 25 ^{\circ}C$		-	-10.8	А		
Pulse Diode Forward Current	I _{SM}		-	-	-25			
Body Diode Voltage	V_{SD}	$I_S = -1.5 \text{ A}, V_{GS} = 0$		-0.8	-1.2	V		
Body Diode Reverse Recovery Time	t _{rr}		-	30	60	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	L_ 15 A dl/dt = 100 A/vo T = 25 °C	-	12	25	nC		
Reverse Recovery Fall Time	ta	$I_F = -1.5 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	11.5	-	ns		
Reverse Recovery Rise Time	t _b	1	-	18.5	-			

Notes

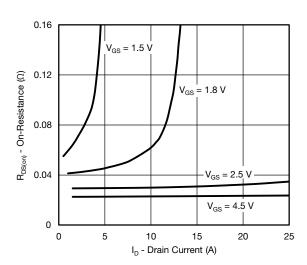
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

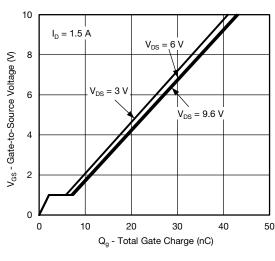




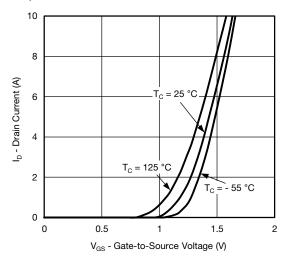
Output Characteristics



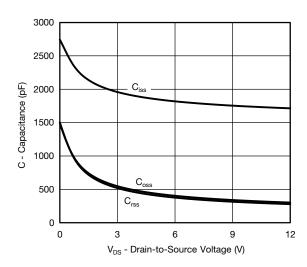
On-Resistance vs. Drain Current and Gate Voltage



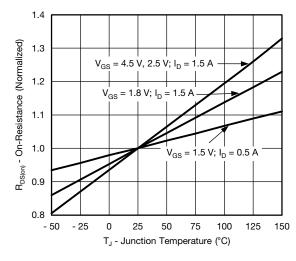
Gate Charge



Transfer Characteristics

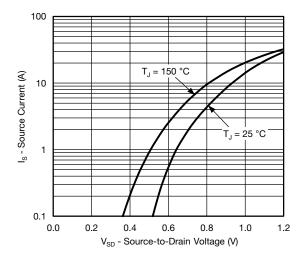


Capacitance

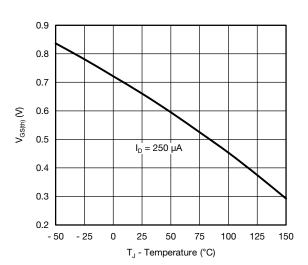


On-Resistance vs. Junction Temperature

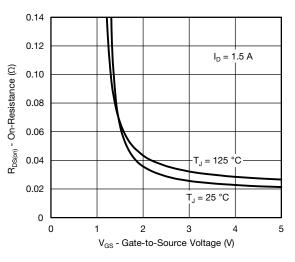




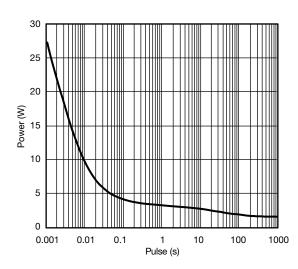
Source-Drain Diode Forward Voltage



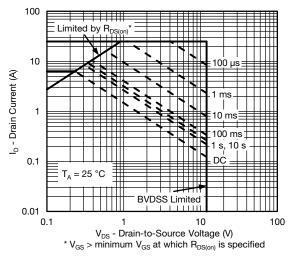
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

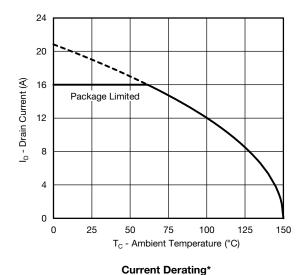


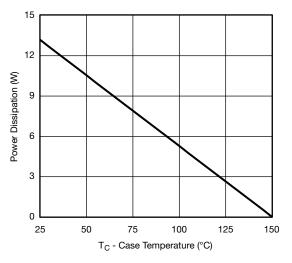
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient



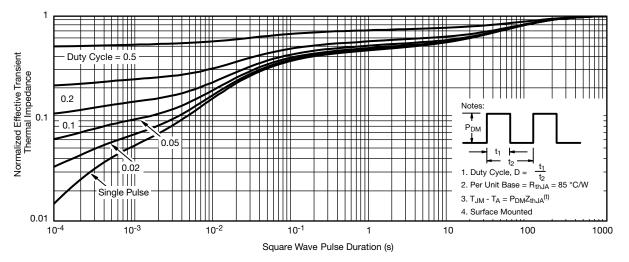




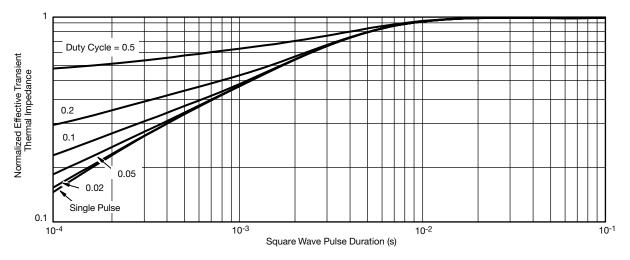
Power Derating

 $^{^{\}star}$ The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

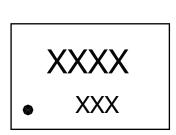


Normalized Thermal Transient Impedance, Junction-to-Case

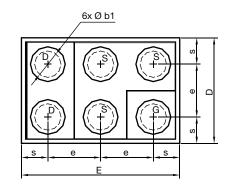
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63553.

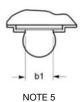
Vishay Siliconix

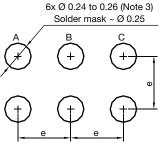
MICRO FOOT®: 6-Bump (1.5 mm x 1 mm, 0.5 mm Pitch, 0.250 mm Bump Height)



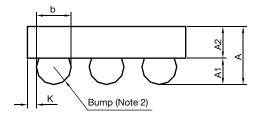
Mark on Backside of Die







Recommended Land Pattern



Notes

(unless otherwise specified)

- 1. Six (6) solder bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser marks on the silicon die back.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.510	0.575	0.590	0.0201	0.0226	0.0232	
A ₁	0.220	0.250	0.280	0.0087	0.0098	0.0110	
A ₂	0.290	0.300	0.310	0.0114	0.0118	0.0122	
b	0.297	0.330	0.363	0.0116	0.0129	0.0143	
b1	0.250			0.0098			
е	0.500			0.0197			
s	0.210	0.230	0.250	0.0082	0.0090	0.0098	
D	0.920	0.960	1.000	0.0362	0.0378	0.0394	
E	1.420	1.460	1.500	0.0559	0.0575	0.0591	
K	0.028	0.065	0.102	0.0011	0.0025	0.0040	

Note

Use millimeters as the primary measurement.

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DWG: 6035

Revison: 20-Apr-15 1 Document Number: 69426



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